

SELF-CALIBRATION OF PHOTODIODES USING THE DUAL-MODE METHOD

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Logan – June 10

Reaching uncertainties of
0.03 % in room temperature
measurements



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DUAL-MODE METHOD



EXPERIMENTAL RESULTS



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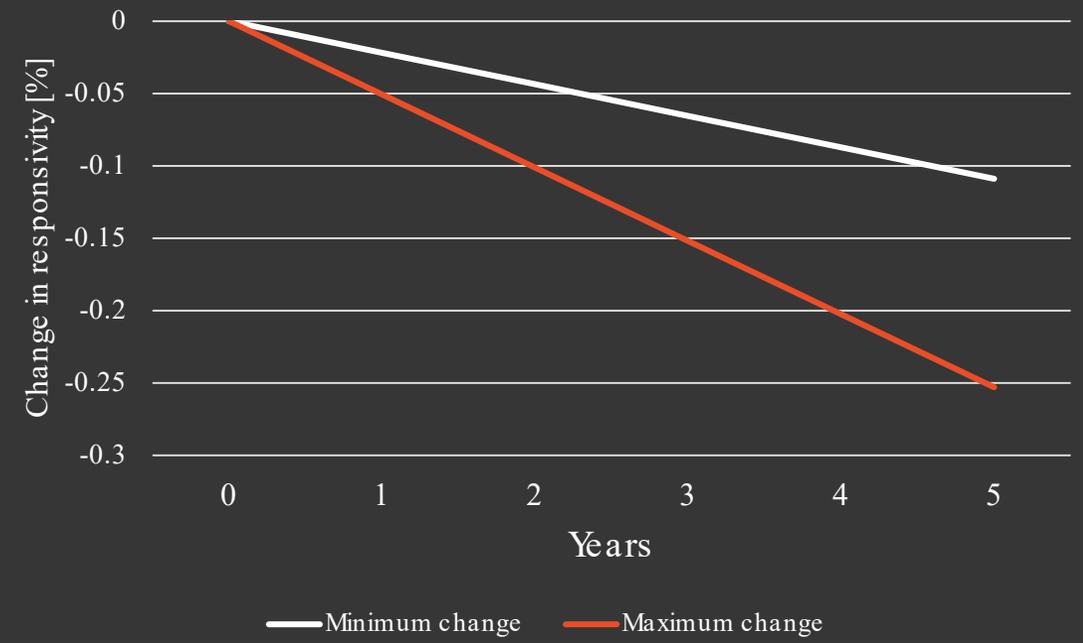


EXPERIMENTAL RESULTS



SUMMARY

Change in responsivity of Hamamatsu S1337 photodiodes @476 nm



Measurements performed at PTB

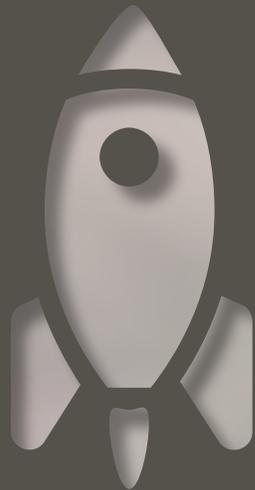
WHERE DO WE NEED SELF-CALIBRATION?



ACCURATE MEASUREMENTS IN REMOTE LOCATIONS

Reduce need for bringing the
instrument to the lab for calibration.

Example: space.



DO WE NEED LIBRATION?



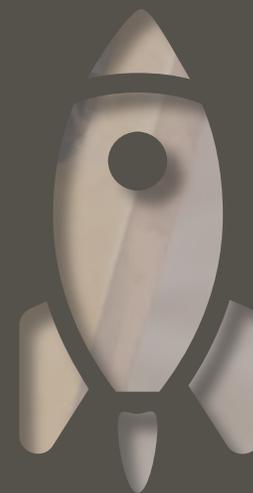
INTEGRATION INTO INSTRUMENTS

Shorter traceability chain.
Examples: spectrometers, power meters.



ACCURATE MEASUREMENTS IN REMOTE LOCATIONS

Reduce need for bringing the
instrument to the lab for calibration.
Example: space.



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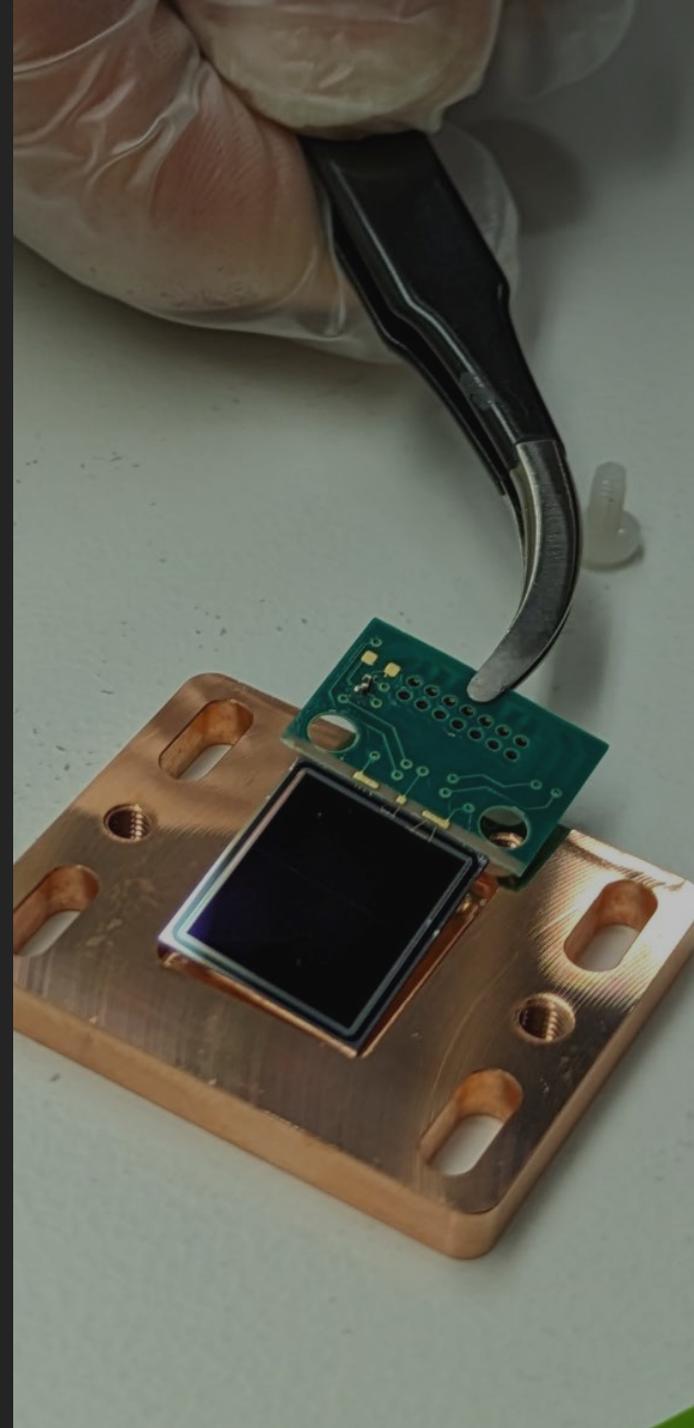
SUMMARY

THE DUAL-MODE METHOD

Calibrating photodiodes: quantify internal losses.

We define the internal quantum deficiency (IQD):

$$\delta = 1 - \frac{P_{opt,pc}}{P_{opt,es}}$$

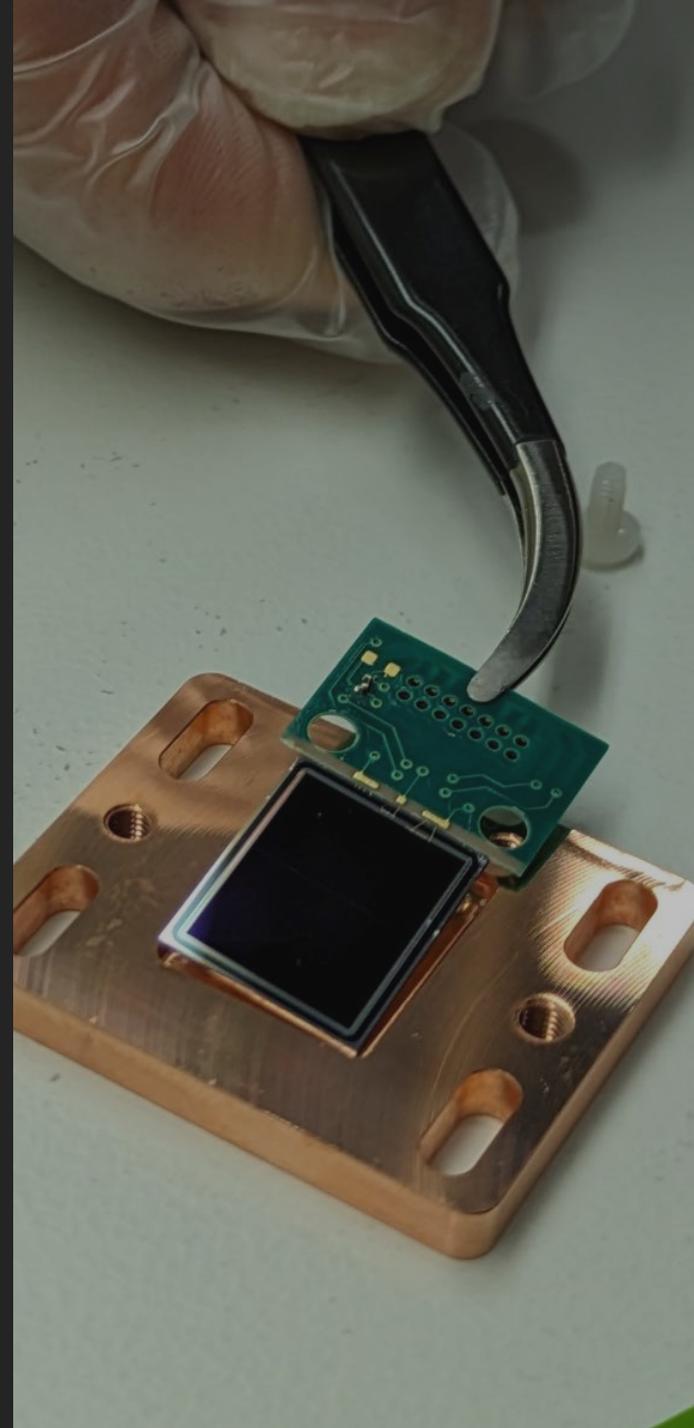


THE DUAL-MODE METHOD

$$\delta = 1 - \frac{P_{opt,pc}}{P_{opt,es}}$$

Optical power assuming ideal photodiode

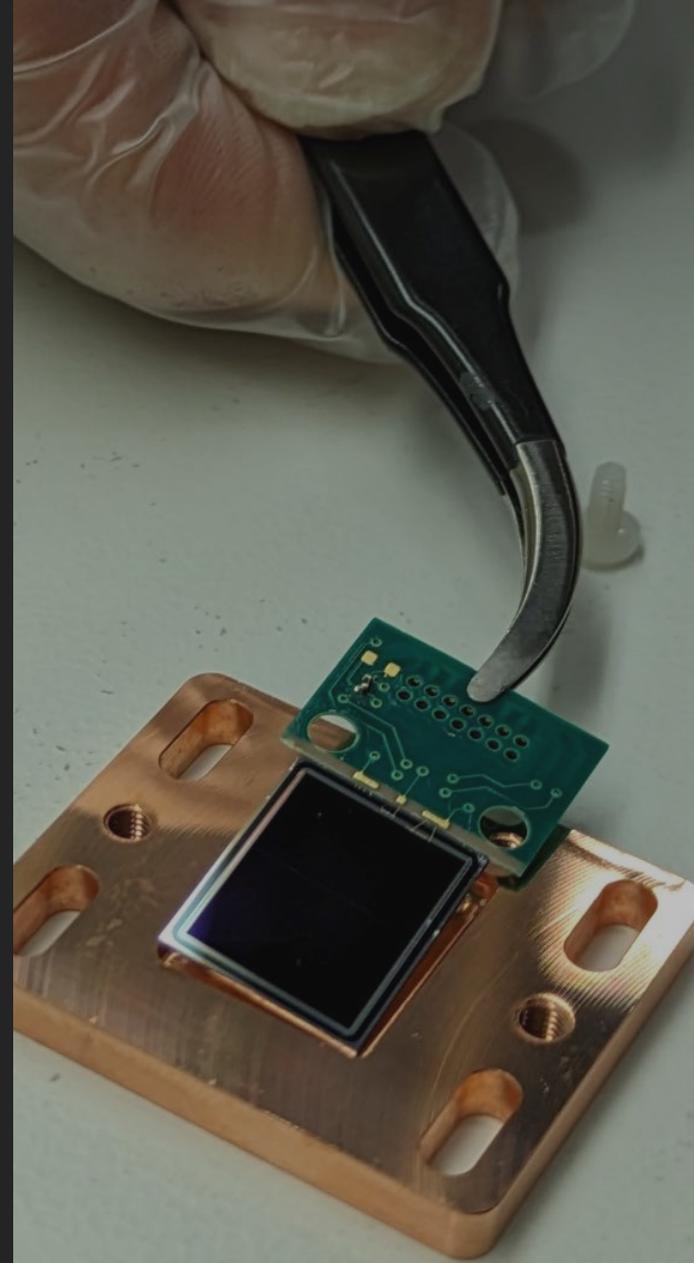
$$P_{opt,pc} = \frac{i_{photo}hc}{e\lambda}$$



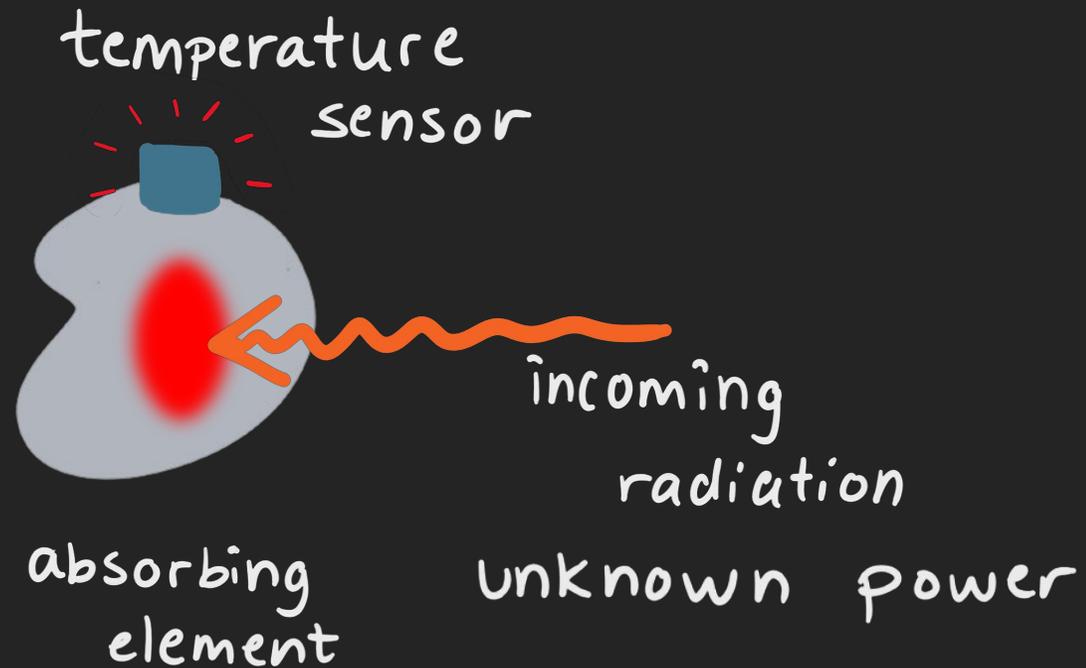
THE
DUAL-MODE METHOD

$$\delta = 1 - \frac{P_{opt,pc}}{P_{opt,es}}$$

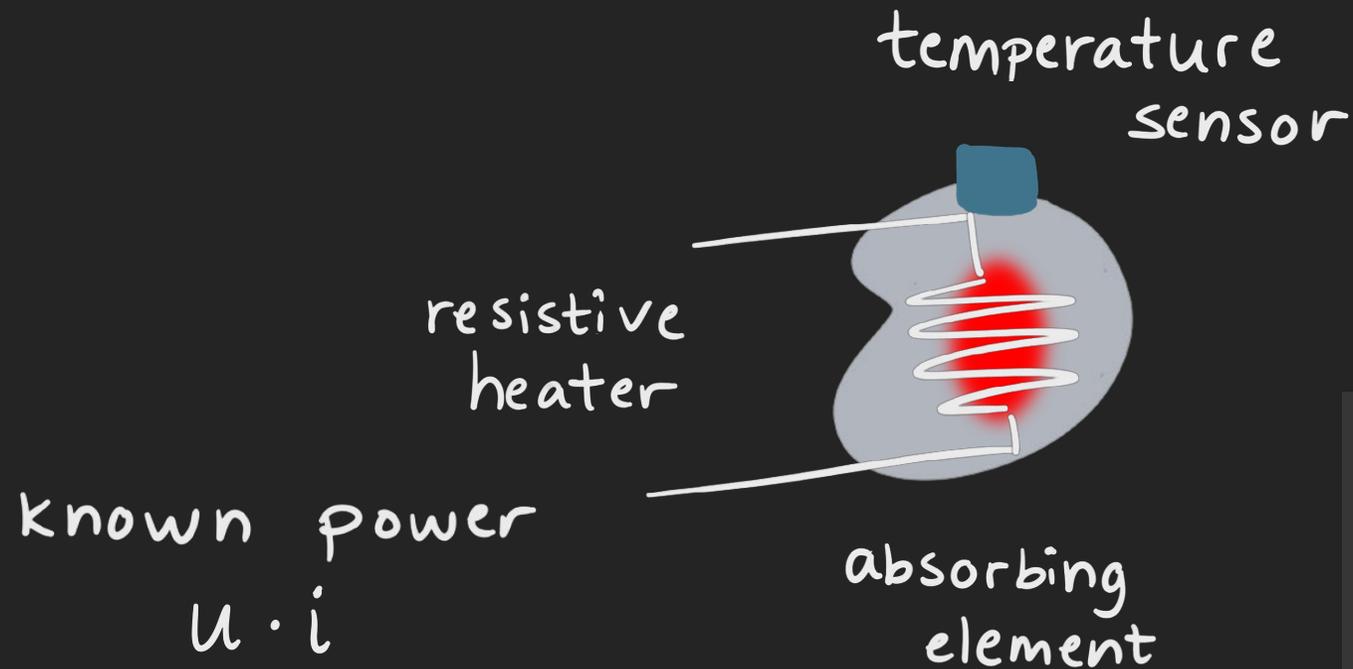
Reference optical power found through
electrical substitution



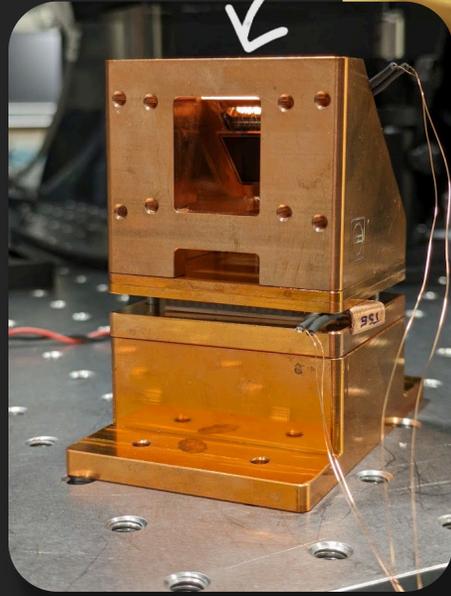
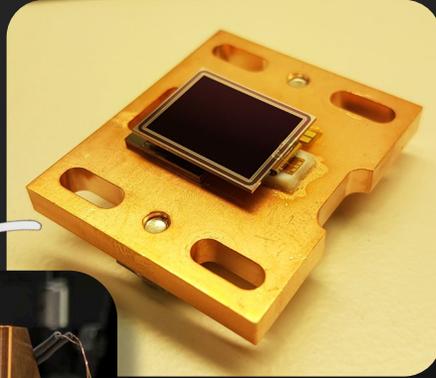
ELECTRICAL SUBSTITUTION



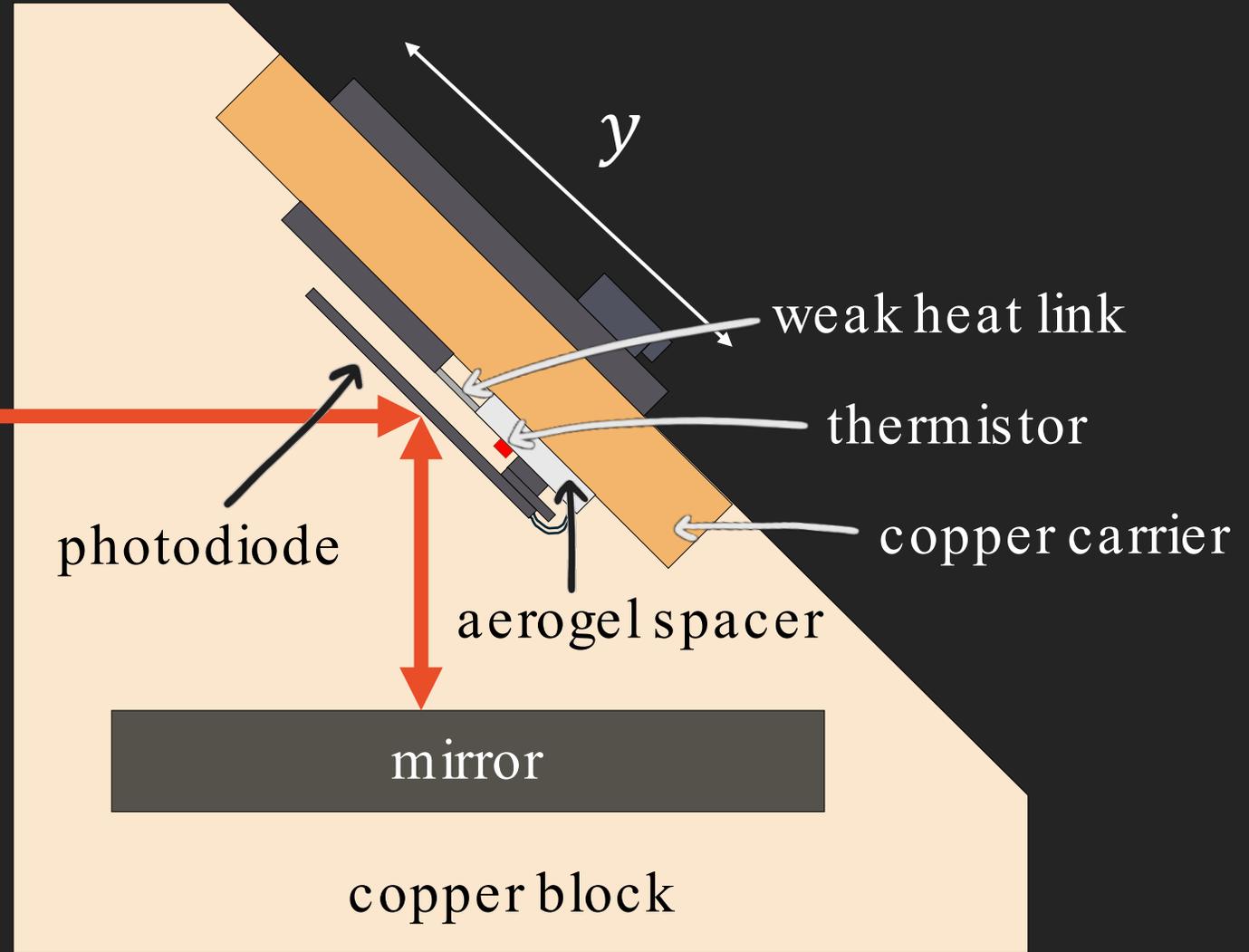
ELECTRICAL SUBSTITUTION

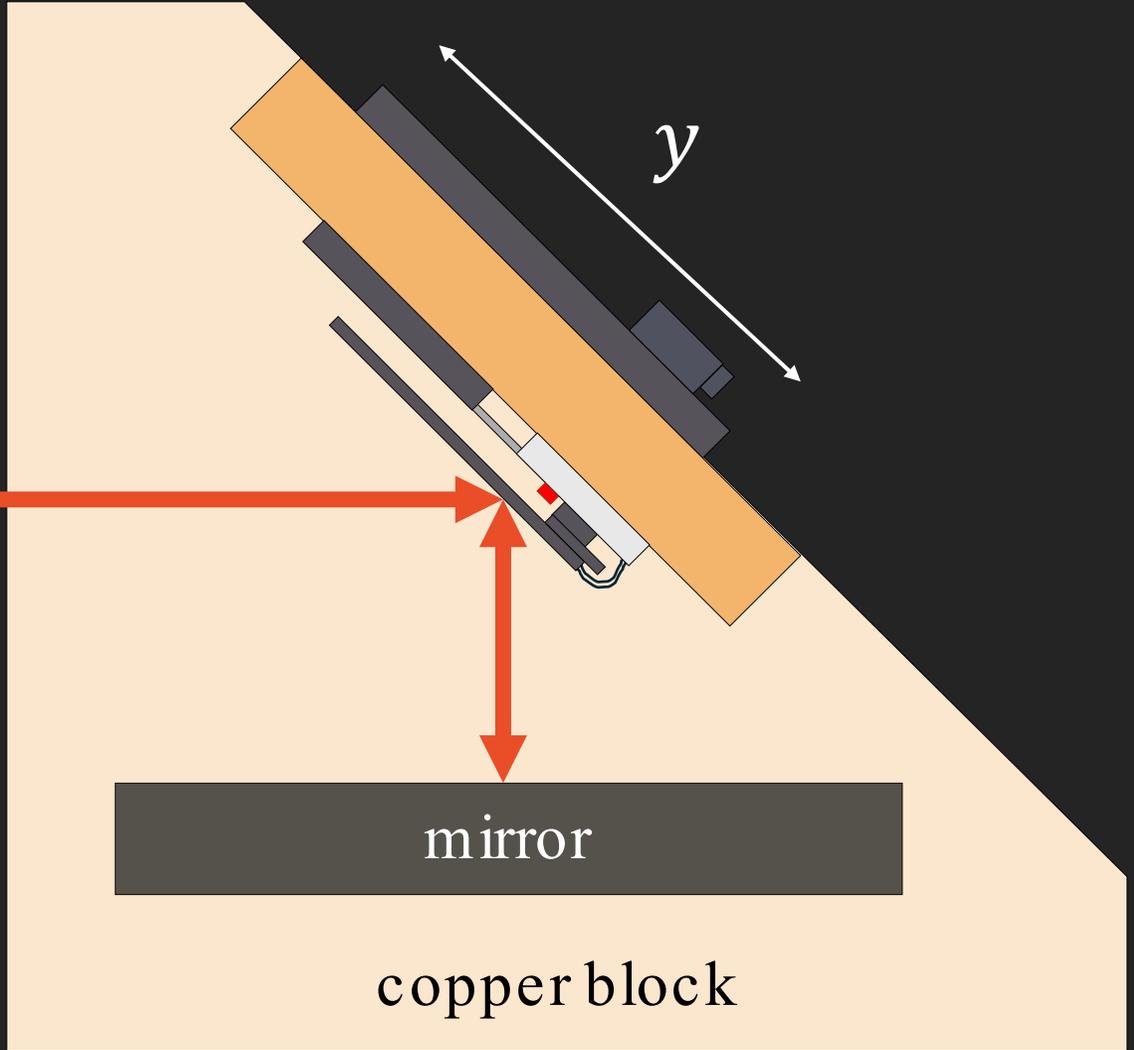
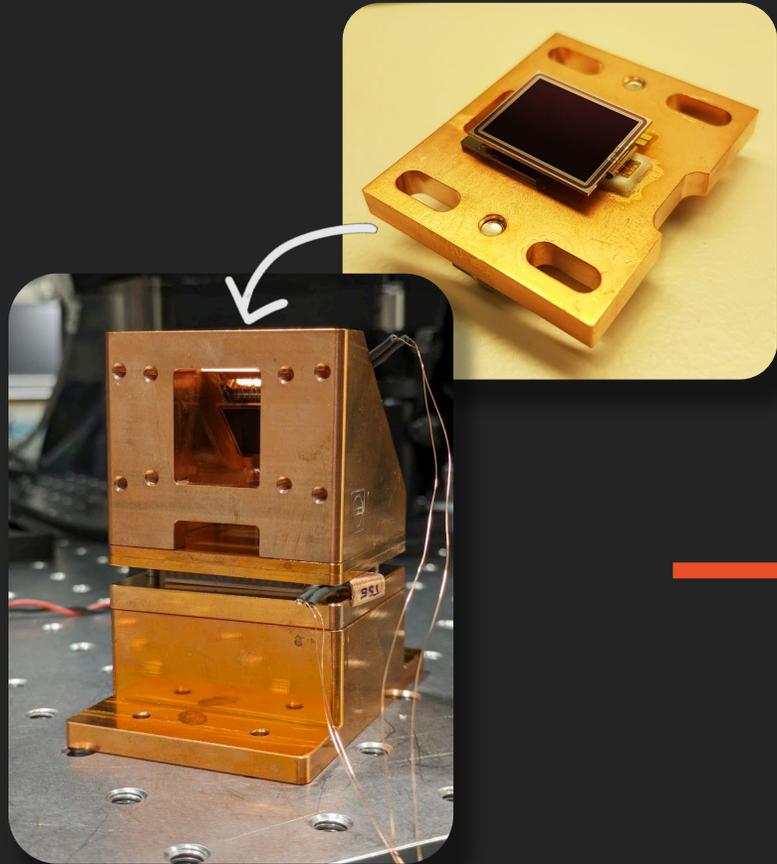


match electrical
and optical power
using temperature

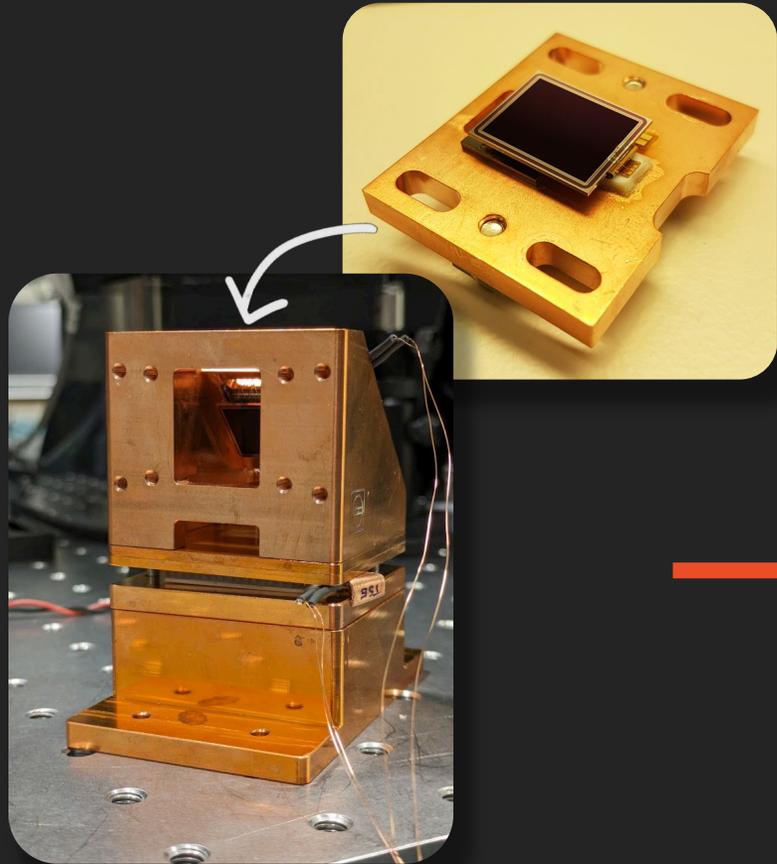


DUAL-MODE MODULE

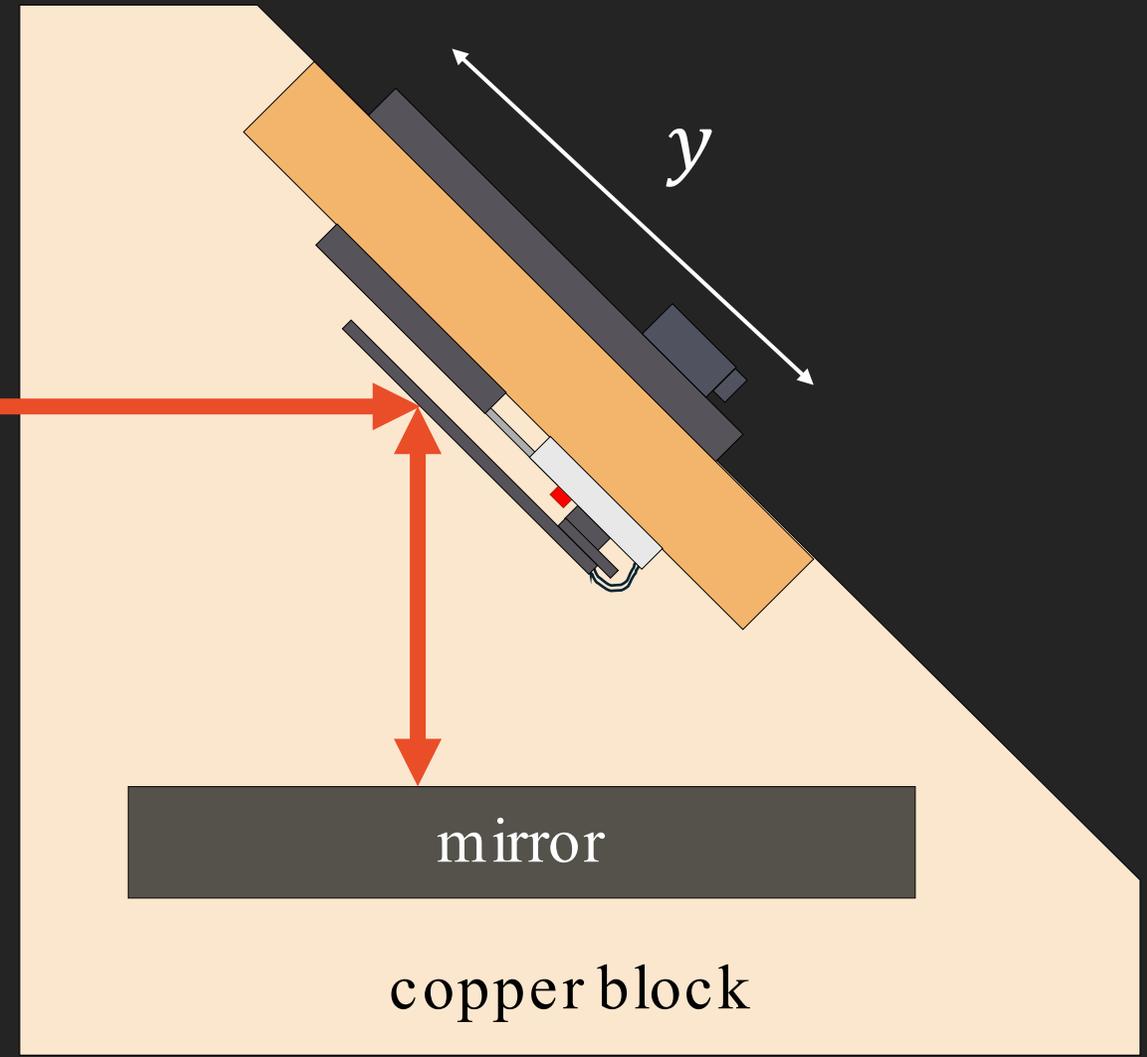


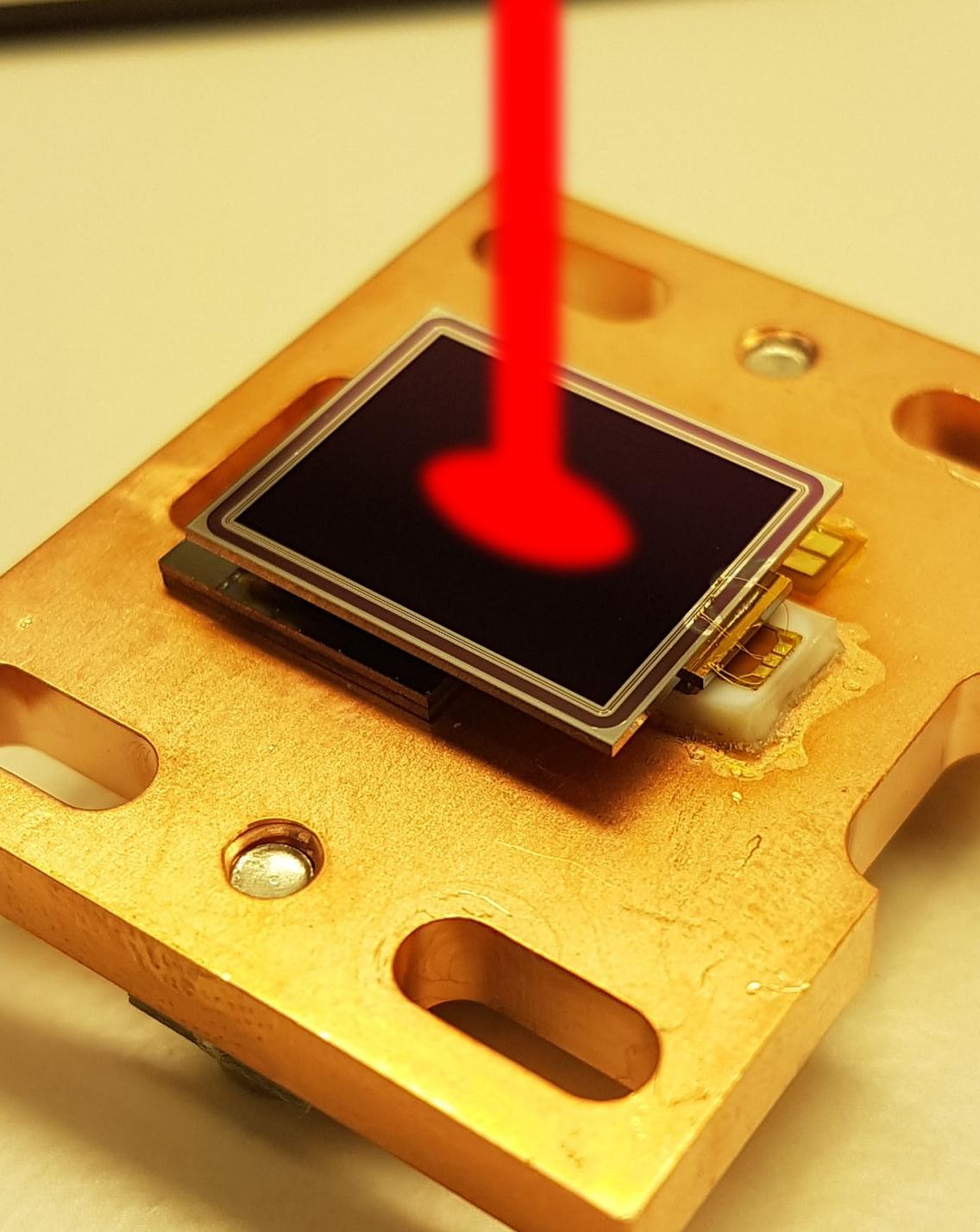


DUAL-MODE MODULE



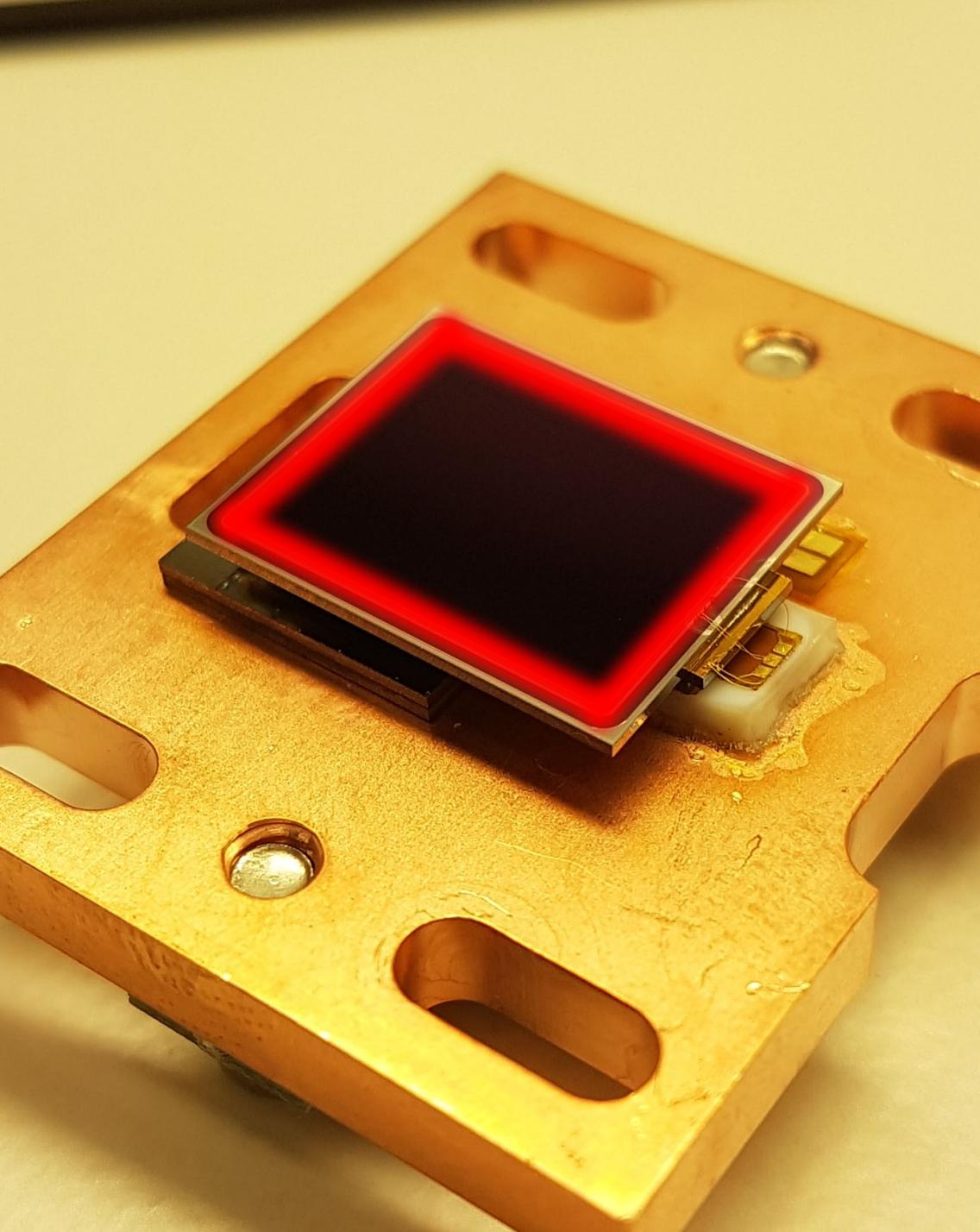
DUAL-MODE MODULE



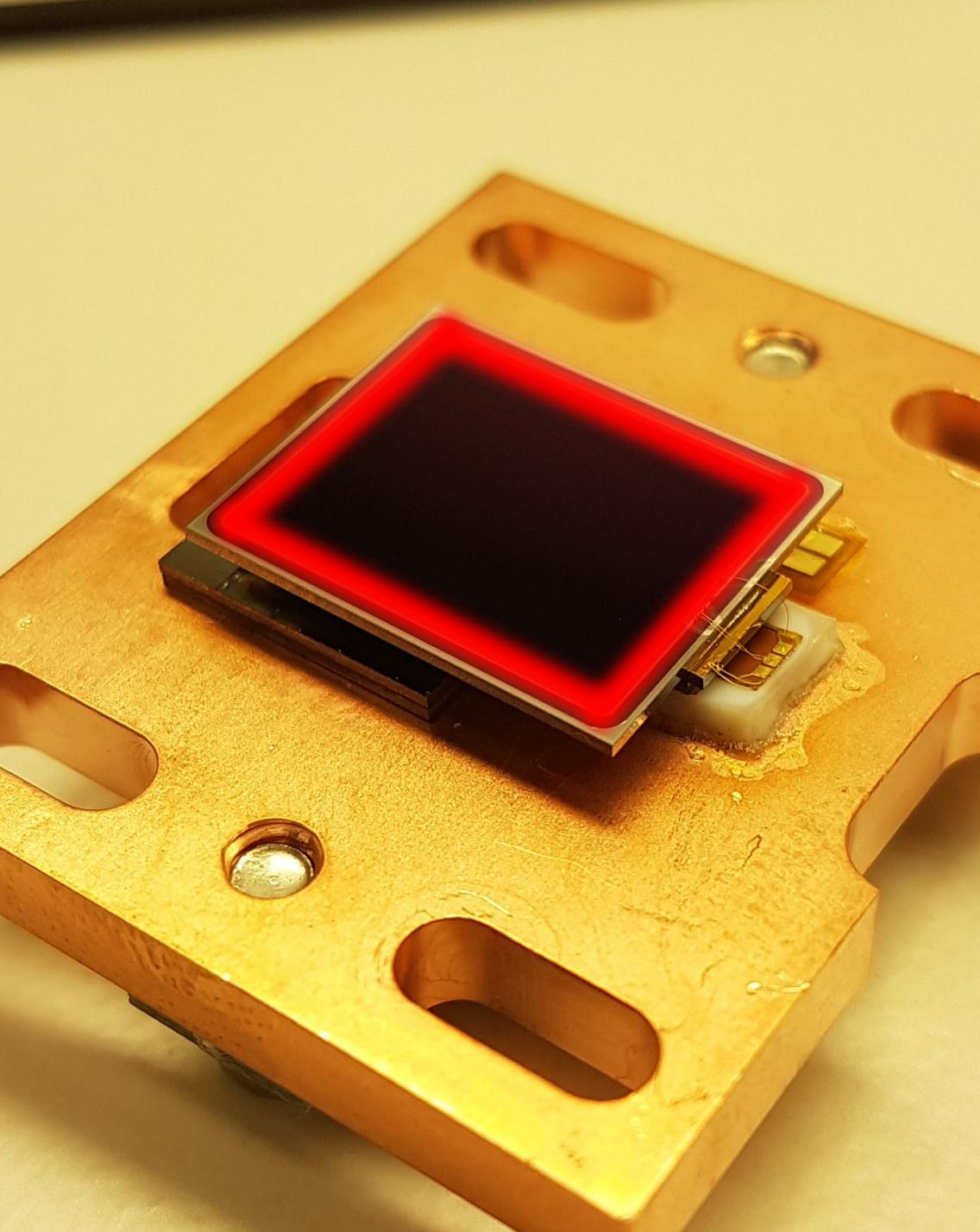


OPTICAL HEATING

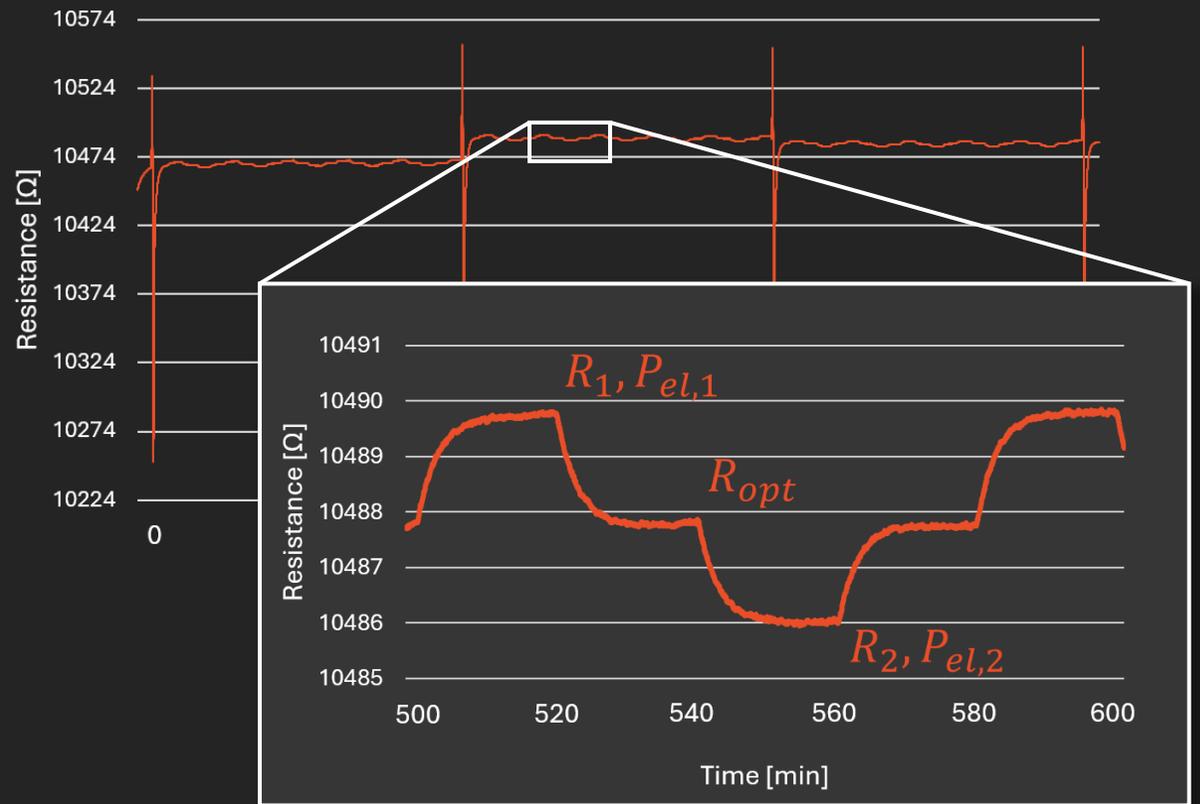
Using the diode as a passive absorbing element



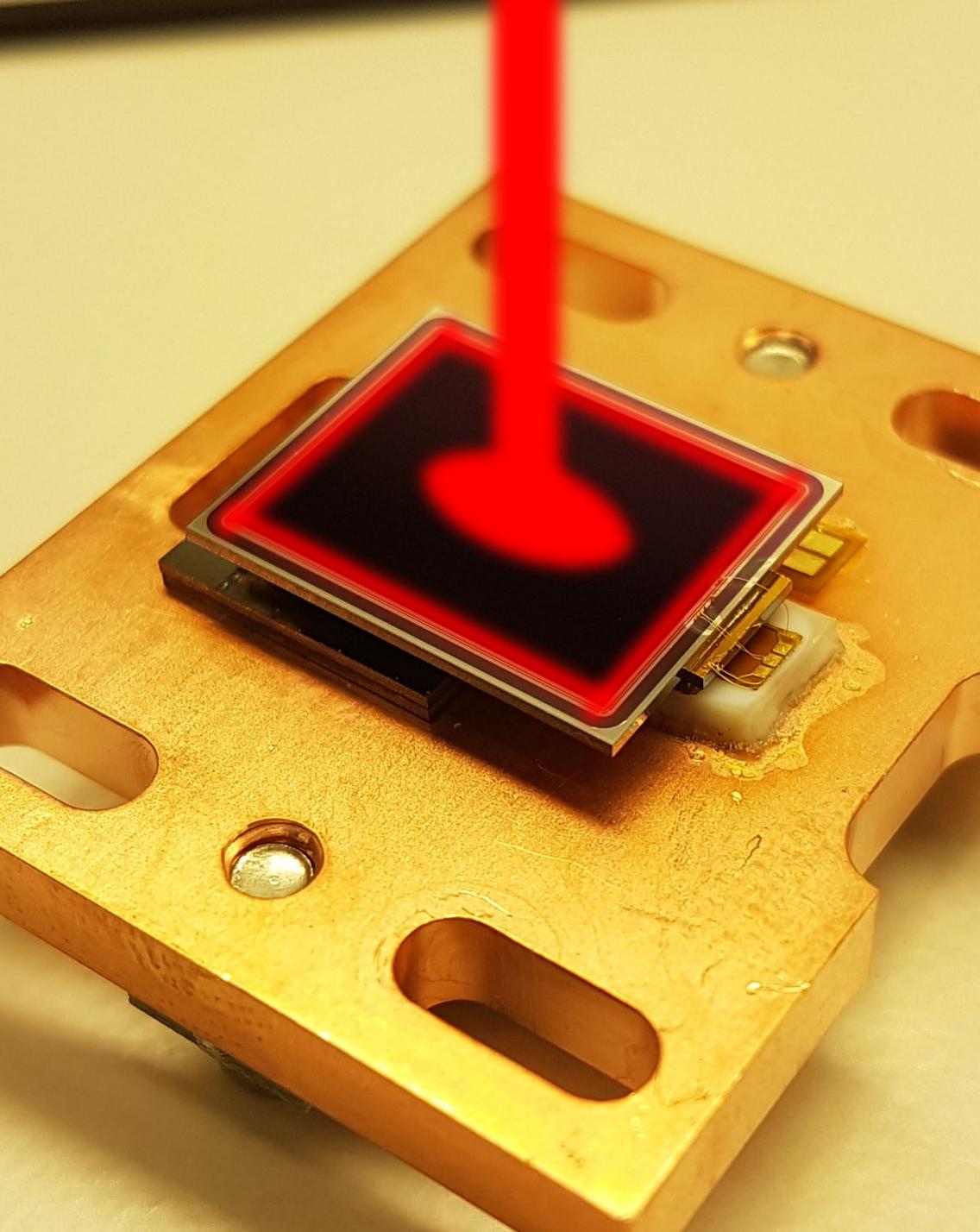
ELECTRICAL HEATING
Forward biasing the diode



TEMPERATURE SIGNAL



$$P_{opt,es} = \frac{(R_{opt} - R_1)}{(R_2 - R_1)} (P_{el,2} - P_{el,1}) + P_{el,1}$$

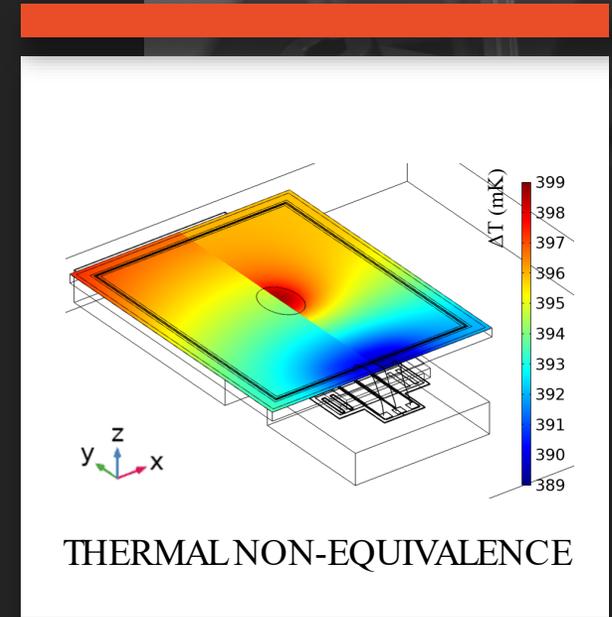
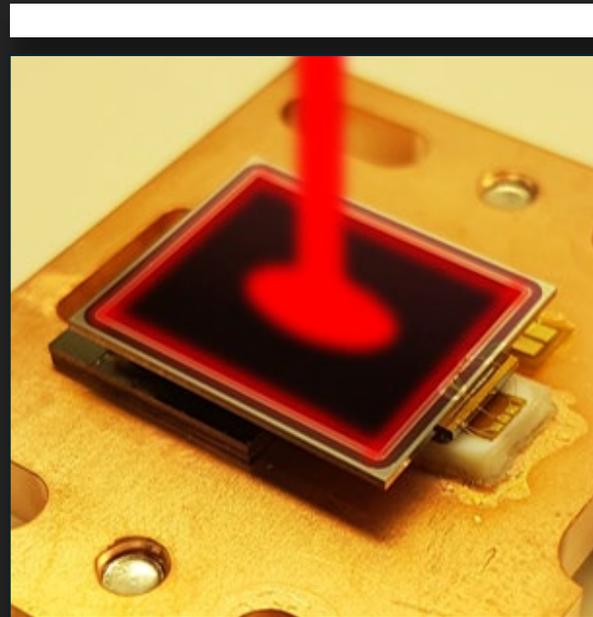
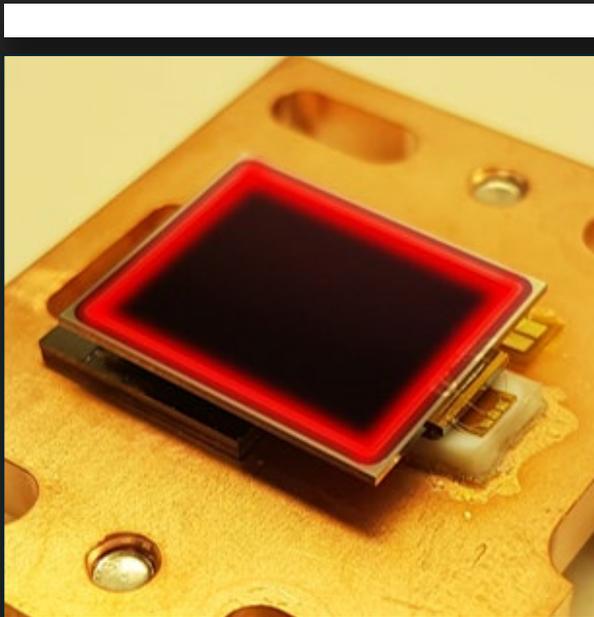


OPTICAL HEATING WITH BACKGROUND ELECTRICAL

Preparation for closed-loop
measurements

$$P_{opt,es} = \frac{(R_{opt} - R_1)}{(R_2 - R_1)} (P_{el,2} - P_{el,1}) + P_{el,1}$$

ELECTRICAL SUBSTITUTION REQUIRE EQUIVALENCE BETWEEN ELECTRICAL AND OPTICAL HEATING



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MOTIVATION



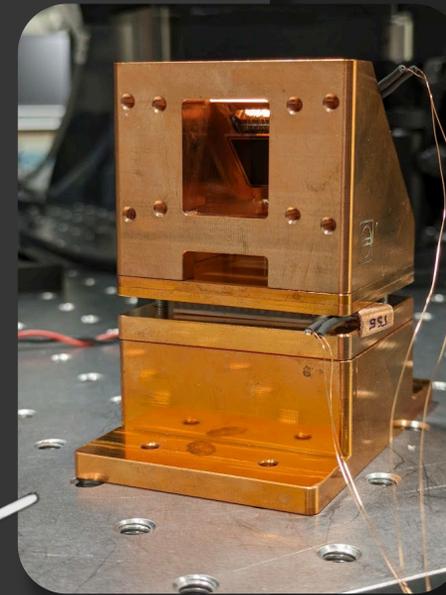
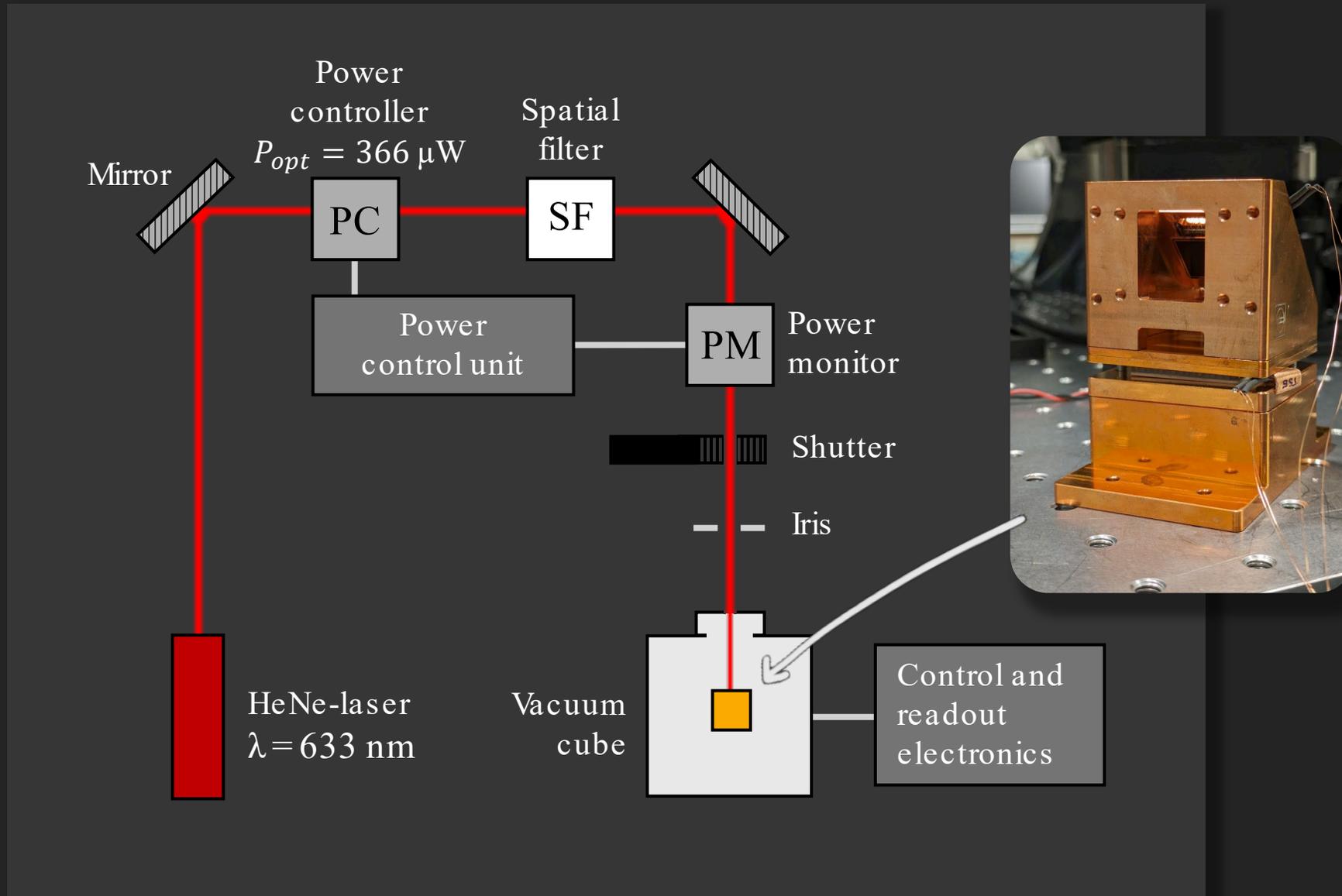
DUAL-MODE METHOD

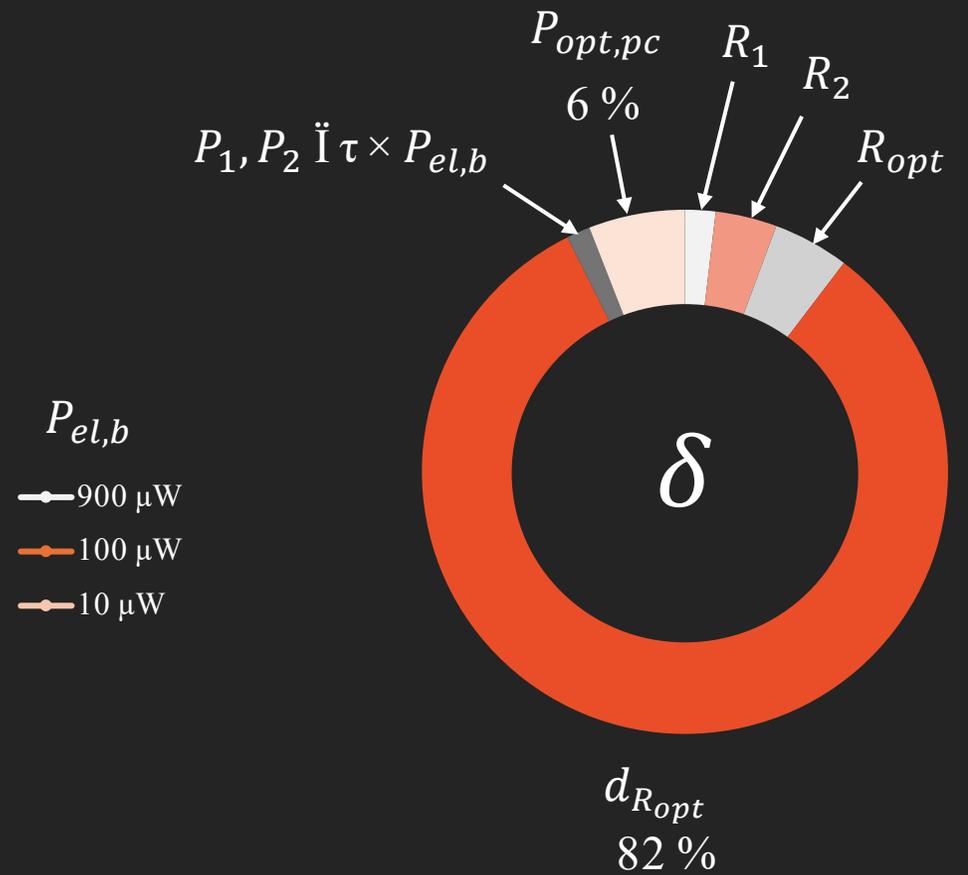
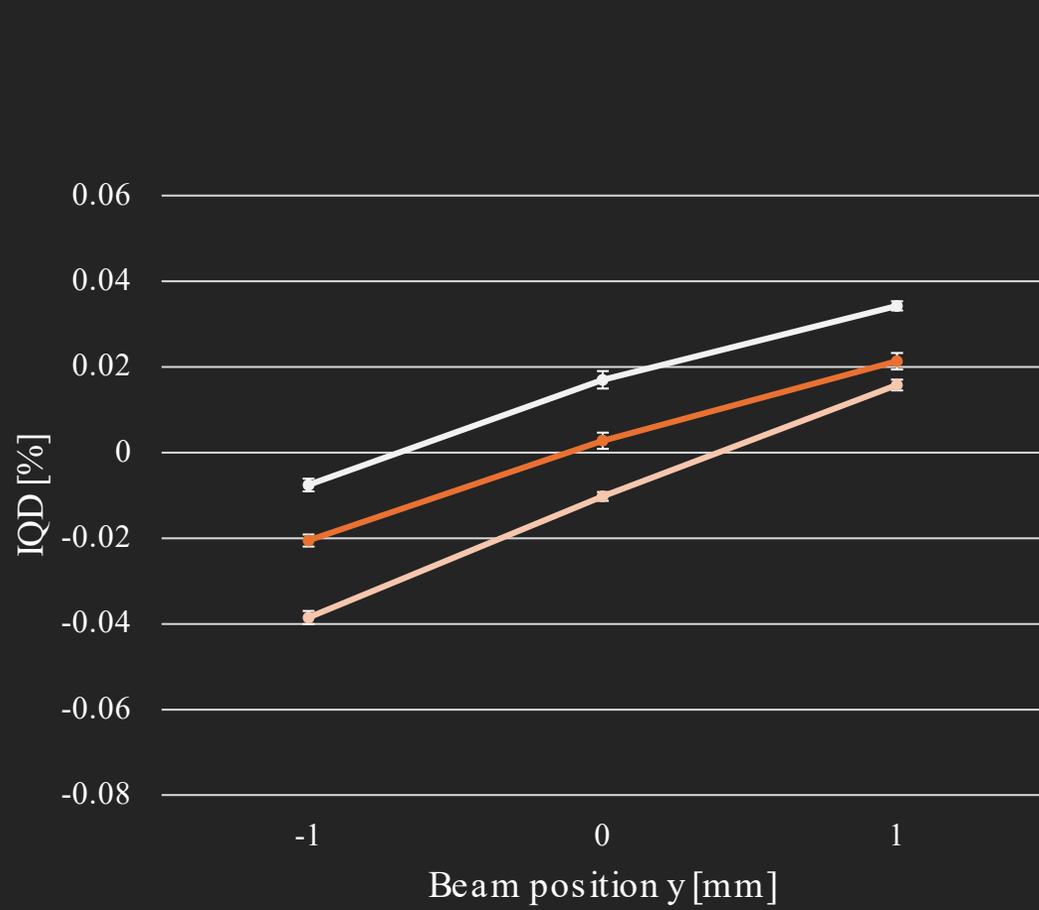


EXPERIMENTAL RESULTS



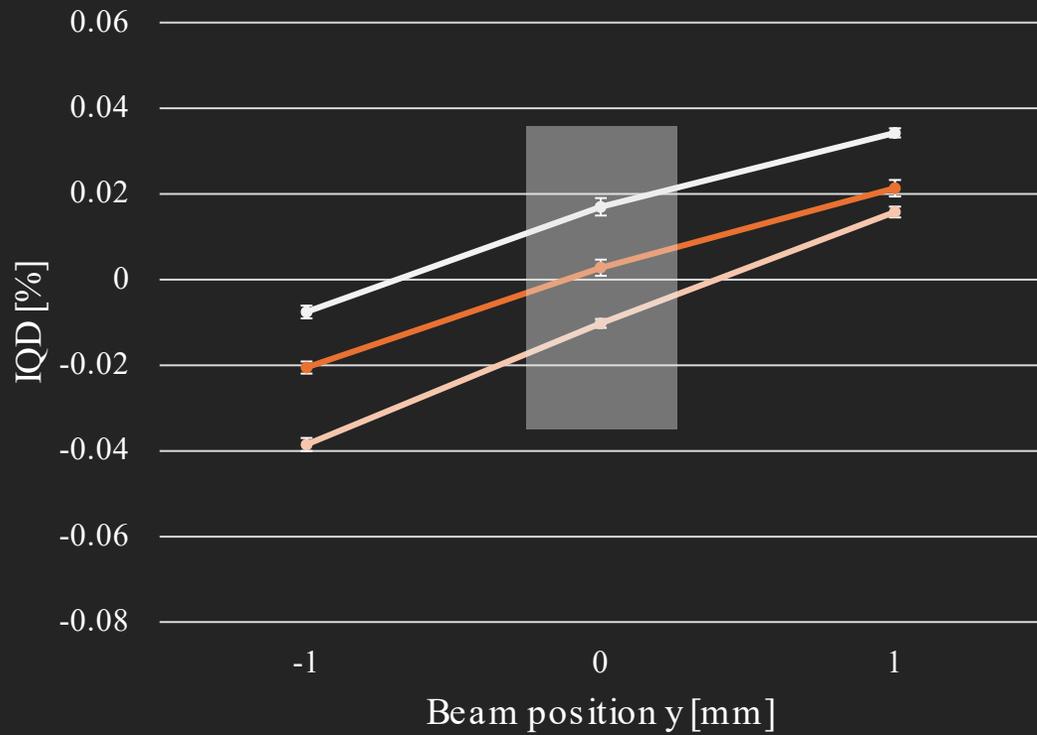
SUMMARY





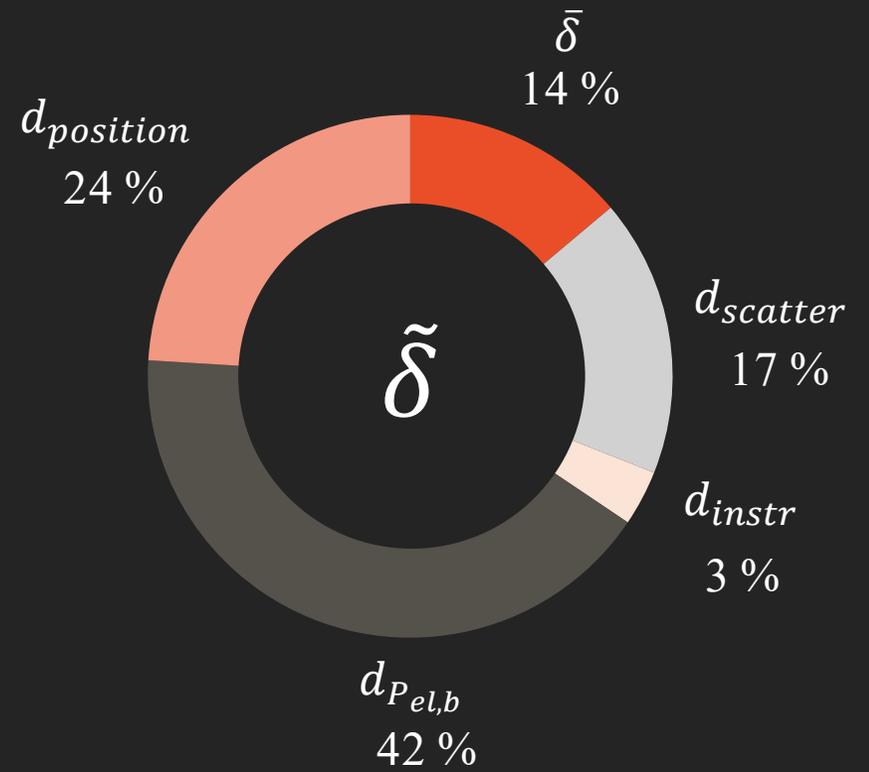
Paper submitted!

$$\tilde{\delta} = \bar{\delta} - d_{scatter} + \underbrace{d_{instr} + d_{P_{el,b}} + d_{position}}_{= 50 \text{ ppm}} + \underbrace{\phantom{d_{instr} + d_{P_{el,b}} + d_{position}}}_{= 0}$$

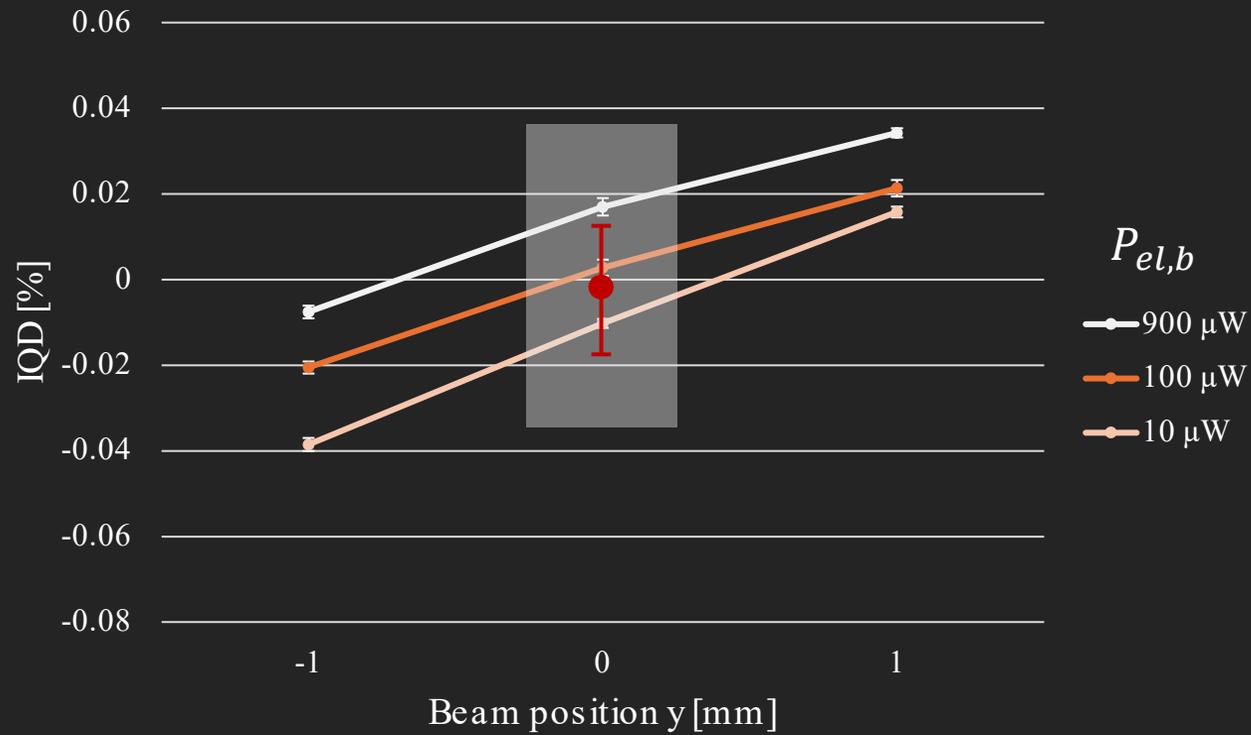


$P_{el,b}$

- 900 μW
- 100 μW
- 10 μW

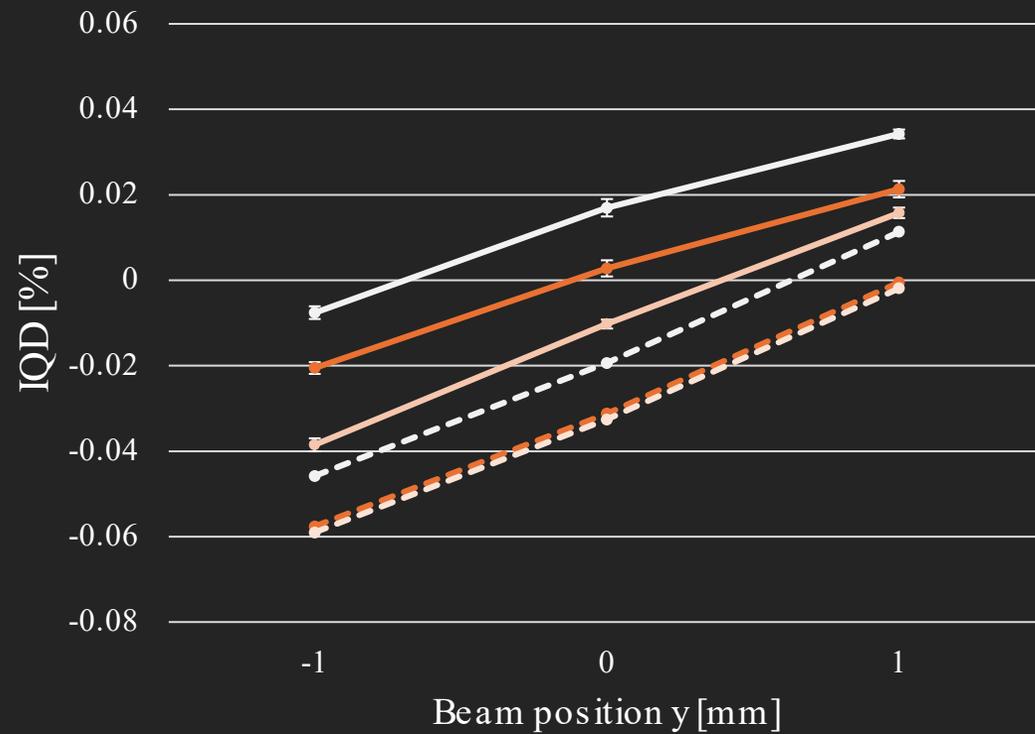


$$\tilde{\delta} = \bar{\delta} - d_{scatter} + \underbrace{d_{instr} + d_{P_{el,b}} + d_{position}}_{= 0} = 50 \text{ ppm}$$



For $y = 0$ and $P_{el,b} = 100 \mu\text{W}$

$$\tilde{\delta} = -22 \text{ ppm} \pm 154 \text{ ppm}$$



Dependence on y -position:
thermal non-equivalence.

Fits well with COMSOL
simulations.

Dependence on background
electrical power not captured by
the model.

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SUMMARY AND OUTLOOK

Results

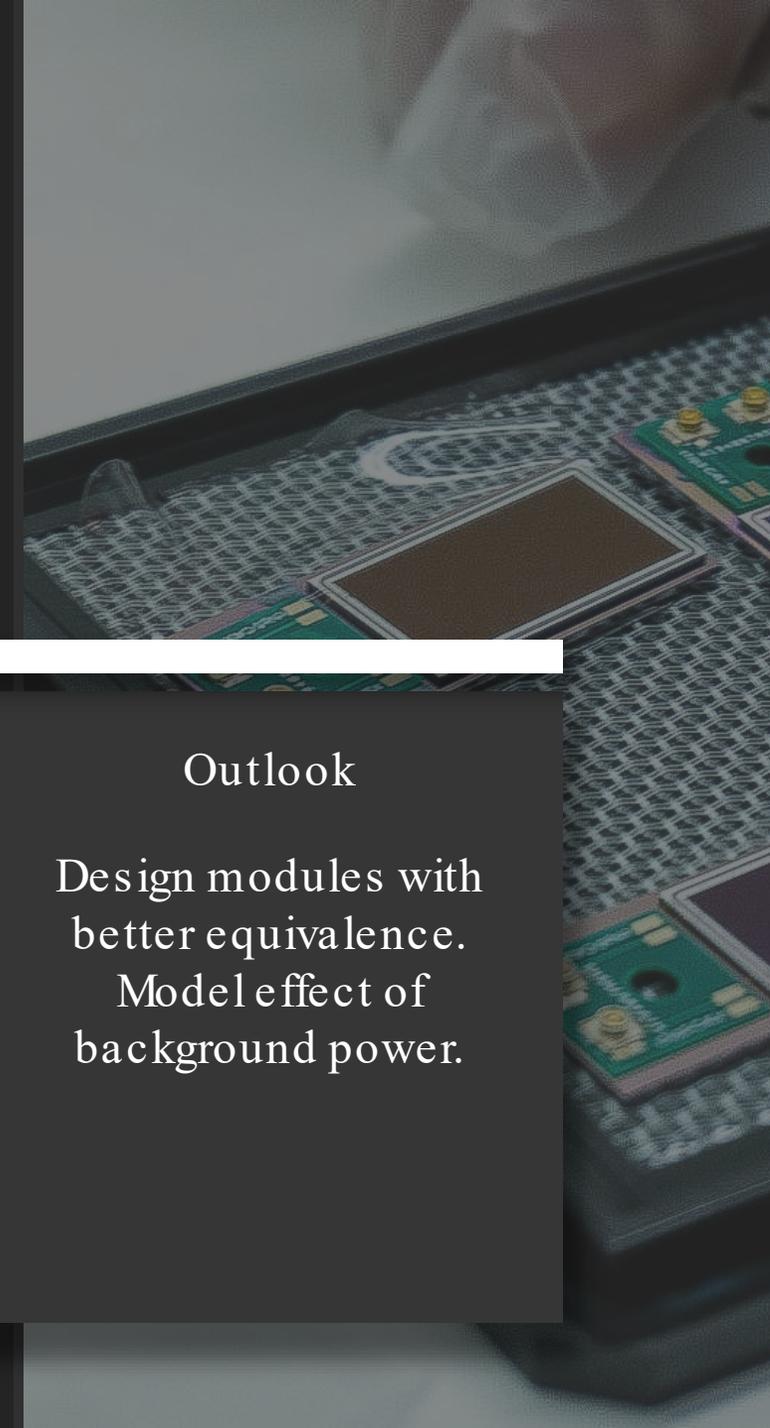
Room temperature calibration with uncertainty at 0.03 % (k=2).

Limitations

Limited by thermal non-equivalence and background power.

Outlook

Design modules with better equivalence. Model effect of background power.



QUESTIONS?



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SCALEUP

<https://scaleup.aalto.fi/>

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